

# ISR Data Analysis & Fitting 2

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**Statistics**

**Least Squares & Maximum Likelihood**

**ISR Fitting**

**Resolution**

**Advanced Processing**

**Estimating functions**

## Statistics

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# Random Variables

- ▶ The probability of an event is a number between 0 and 1 that is to represent the outcomes of the event divided by the number of experiments [PP02]
- ▶ Random variables: A number that is assigned to the outcome of every experiment
- ▶ R.V. can be described using distributions
- ▶ CDF  $F_x(x) = P\{X \leq x\}$
- ▶ PDF  $f_x(x) \triangleq \frac{dF_x(x)}{dx} = \lim_{\Delta x \rightarrow 0} \frac{P\{x \leq X \leq x + \Delta x\}}{\Delta x}$

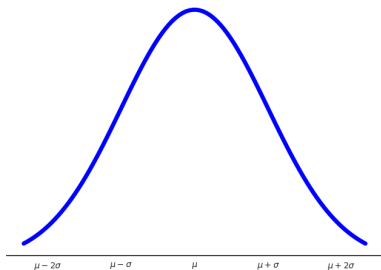
# Normally Distributed R.V.

- ▶ Normally distributed R.V. have the following PDF:

$$f(x) = \frac{1}{\sqrt{2\pi\sigma^2}} \exp \left\{ -\frac{(x - \mu)^2}{2\sigma^2} \right\}$$

- ▶  $\mu$  is mean,  $\sigma^2$  is variance

- ▶ CLT: Sum of independent R.V.s converges to normally distributed R.V.



# Multiple R.V.

- ▶ R.V. can include information on other R.V. which can be expressed through joint distributions

$$f(\mathbf{x}) = \frac{1}{\sqrt{(2\pi)^n \det(C)}} \exp \left\{ -\frac{1}{2} \mathbf{x} \mathbf{C}^{-1} \mathbf{x}^T \right\}$$

- ▶ If independent  $f(x_1, x_2, \dots, x_n) = f(x_1)f(x_2)\dots f(x_n)$
- ▶ Instead of finding whole PDF often use correlation instead  $E\{X_1, X_2\}$

# Estimation

- ▶ Often need to estimate statistics on R.V.
- ▶ Determine the mean of  $n$  of sequence  $X_1, X_2, \dots, X_n$

$$\hat{\mu} = \frac{1}{n} \sum_{i=1}^n x_i$$

- ▶ Estimation theory can give bounds on uncertainty
- ▶ Correlation estimation

$$\widehat{C}_{xy} = \frac{1}{n} \sum_{i=1}^n x_i y_i$$

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# Why least squares?

## Least squares problem

$$\underset{\theta}{\text{minimize}} \quad \frac{1}{2} \|y - h(\theta)\|_2^2$$

Why least squares and not another error metric?

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- ▶ Everybody uses it
- ▶ It's easy: closed-form linear solution for linear least-squares

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# Why least squares?

## Least squares problem

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Why least squares and not another error metric?

- ▶ Everybody uses it
- ▶ It's easy: closed-form linear solution for linear least-squares
- ▶ It punishes large errors more than small errors
- ▶ It gives the **maximum likelihood** solution when errors follow the Normal distribution

# Likelihood function

With  $Y \sim f(y | \theta)$ , the likelihood function is defined as:

$$\mathcal{L}(\theta) \equiv f(y | \theta)$$

for parameters  $\theta$  and a realization  $y$ .

## Measurements with zero-mean Gaussian noise

$$Y = h(\theta) + N \quad \text{with} \quad N \sim \mathcal{N}(0, \Sigma) \quad \implies \quad Y \sim \mathcal{N}(h(\theta), \Sigma)$$

Likelihood:

$$\mathcal{L}(\theta) = f(y | \theta) = \frac{1}{\sqrt{\det(2\pi\Sigma)}} e^{-\frac{1}{2}(y-h(\theta))^\top \Sigma^{-1}(y-h(\theta))}$$

Log-likelihood with  $\Sigma = \sigma^2 \mathbf{I}$ :

$$l(\theta) = -\frac{k}{2} \log(2\pi\sigma^2) - \frac{1}{2\sigma^2} \|y - h(\theta)\|_2^2$$

$$\underset{\theta}{\text{maximize}} \mathcal{L}(\theta) \iff \underset{\theta}{\text{minimize}} \frac{1}{2} \|y - h(\theta)\|_2^2$$

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# Maximum likelihood

## A useful framework

- ▶ Turns parameter estimation problem into optimization problem
- ▶ Many R.V.s are Gaussian (central limit theorem)
  - ▶ Least squares is nice!
- ▶ Estimates come with error bars governed by the curvature of the log-likelihood function (see Fisher information)

## A Bayesian perspective

- ▶ Maximum a posteriori (MAP) estimate maximizes

$$P(\theta | y) = \frac{f(y | \theta)P(\theta)}{P(y)}$$

- ▶ With uniform prior  $P(\theta)$ , MAP = ML
- ▶ Other priors yield regularized ML problems
  - ▶ e.g. Laplace prior yields  $l_1$ -regularization



# Under-determined systems of equations

Not enough measurements to constrain unknown values:

$$\begin{bmatrix} y \end{bmatrix} = \begin{bmatrix} A \end{bmatrix} \begin{bmatrix} x \end{bmatrix}$$

Measurement      Model      Unknown

- ▶ Infinite number of solutions
- ▶ Often have prior information about the true solution (e.g. sparsity) that can make the problem well-conditioned

# Theory of compressed sensing

Finding the sparsest solution is hard in general.

## Definition

**Compressed sensing** is a theory to guarantee solution of an under-determined set of equations.

## Approximate guidelines for application

- ▶ Solution known to be sparse
- ▶ Measurements capture the effects of all parameters
- ▶ Minimum number of measurements on the order of the solution sparsity (number of nonzeros)

## Benefit

Can solve an easy convex optimization problem instead of a hard combinatorial problem.

# Equivalent convex optimization problem

## Sparsest solution to noisy measurements

Find sparsest  $x$

subject to  $\|y - A(x)\|_2 < \eta$

$$\|x\|_2^2 = \sum_k |x_k|^2$$

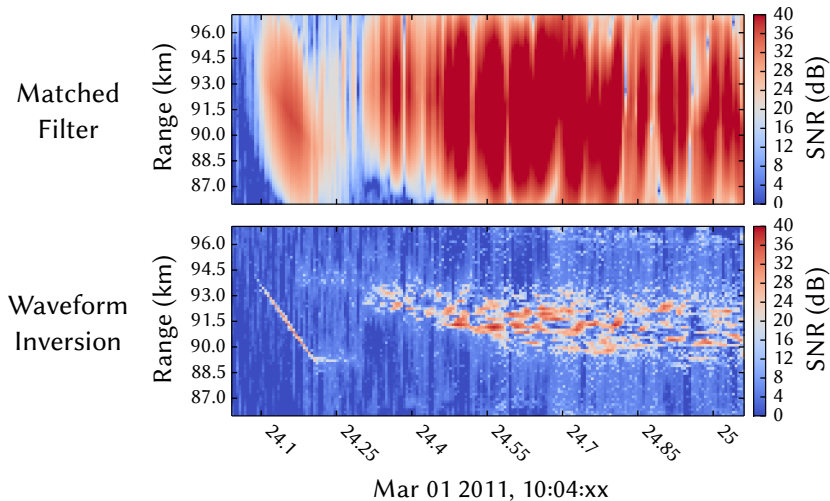
## $l_1$ -regularized least-squares (convex)

minimize  $\frac{1}{2}\|y - A(x)\|_2^2 + \lambda\|x\|_1$

$$\|x\|_1 = \sum_k |x_k|$$

The  $l_1$ -norm promotes sparsity!

# Example: waveform inversion for meteor echo



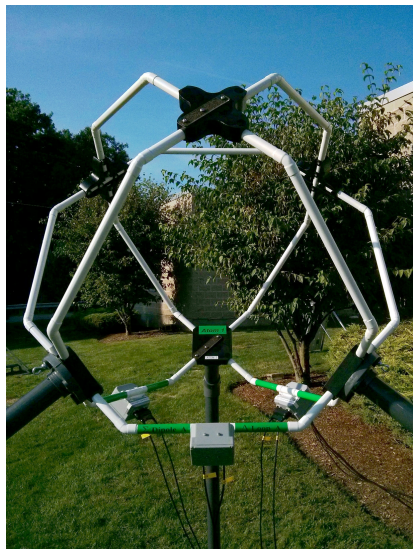
# ML application: electromagnetic vector sensor

## Six elements

- ▶ 3 orthogonal dipole and loop elements with common phase center

## Maximum information

- ▶ Measures complete electromagnetic field at a point
- ▶ Sensitive to all directions and polarizations



Atom antenna



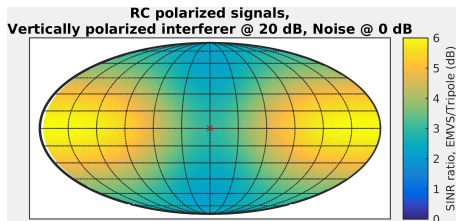
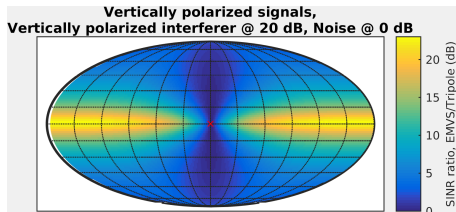
# Vector sensor benefits

## Vector sensor benefits

- ▶ Magnitude/direction/polarization of multiple sources in single snapshot
- ▶ Frequency-independent beamforming
- ▶ Null out interfering direction/polarization

### Tripole comparison (right)

- ▶ Increased sensitivity, especially in case of interference



# Measurements

## Measurement equation

- ▶ Collection of independent point sources
- ▶ Sources distributed equally in solid angle on surrounding sphere
- ▶ Arbitrary polarization in horizontal/vertical basis

$$\text{▶ } r_n = \begin{bmatrix} A_h & A_v \end{bmatrix} \begin{bmatrix} h_n \\ v_n \end{bmatrix} + w_n$$

Measurement  
vector

Direction  
steering vectors

Source  
magnitudes/phases

Noise

## Second-order statistics

- ▶ Sufficient statistic using sample covariance:  $S = \frac{1}{N} \sum_{n=0}^{N-1} r_n r_n^*$



# Imaging problem formulation

- ▶ Assume zero-mean complex normal:

$$\begin{bmatrix} h_n \\ v_n \end{bmatrix} \sim \mathcal{CN}(0, \Sigma) \quad w_n \sim \mathcal{CN}(0, \sigma \mathbf{I}) \quad \forall n$$

- ▶ Entries of  $\Sigma$  give magnitude/polarization for source directions
- ▶ Solve covariance estimation problem:

$$\begin{aligned} & \underset{\Sigma}{\text{minimize}} && H(\Sigma) \\ & \text{subject to} && \Sigma \succeq 0 \end{aligned}$$

## Maximum likelihood objective

$$H_{ml}(\Sigma) = \log \det(A\Sigma A^* + \sigma \mathbf{I}) + \text{tr}((A\Sigma A^* + \sigma \mathbf{I})^{-1} S)$$

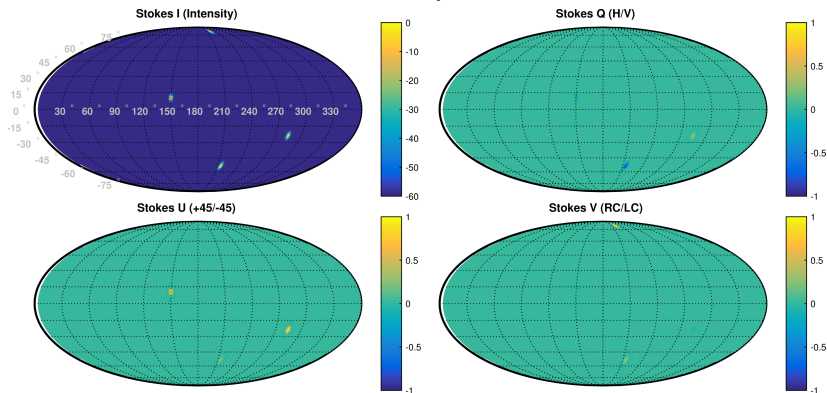


# Sky map using Stokes parameters

- ▶  $\Sigma$  is composed of **diagonal** blocks (independent sources)

$$\Sigma = \begin{bmatrix} \Sigma_{hh} & \Sigma_{hv} \\ \Sigma_{hv}^* & \Sigma_{vv} \end{bmatrix} = \frac{1}{2} \begin{bmatrix} \text{diag}(I + Q) & \text{diag}(U - iV) \\ \text{diag}(U + iV) & \text{diag}(I - Q) \end{bmatrix}$$

- ▶ Can write  $\Sigma$  in terms of Stokes parameters  $I, Q, U, V$



Source sky map, covariance described with Stokes parameters

# Outline

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**ISR Fitting**

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# Statistics with ISR Data

- ▶ ISR data can be modeled as a Normally distributed random variable
  - ▶ The value of the parameter is an estimate of the mean of that process
  - ▶ The error bar value is the estimate standard deviation of the for random variable.
- ▶ Issues with this model
  - ▶ Correlation between different parameters
  - ▶ Bias with the measurement
  - ▶ Correlation between different measurements, e.g. close range gates
- ▶ Need to be careful in applying assumptions
  - ▶ Can impact on how you do your analysis

# Fitted Data

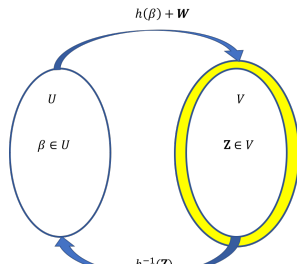
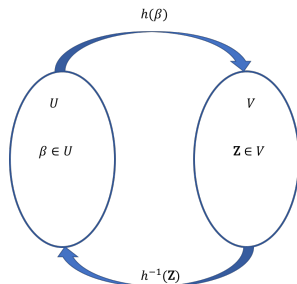
- ▶ Least Squares

$$\hat{\beta}_{LS} = \arg \min_{\beta} [h(\beta) - \mathbf{Z}]^T \mathbf{C}^{-1} [h(\beta) - \mathbf{Z}]$$

- ▶  $\beta$  the plasma parameter vector
  - ▶  $[N_e, T_e, T_i, \text{etc}]^T$
- ▶  $\mathbf{Z}$  the data
  - ▶ The measured ACF or spectra
- ▶  $\mathbf{C}$  the covariance matrix of the data
- ▶  $h$  function between parameters and data
  - ▶ e.g. [KM11]

# ISR Fitting

- ▶ Find parameters for a given set of data
- ▶ Find a function to move from one space to another
- ▶ Noise can increase size of space



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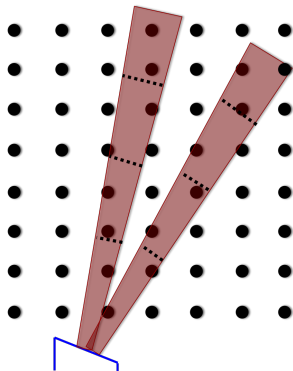
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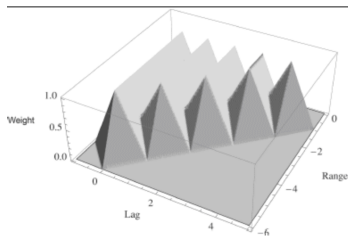
# Spatial Ambiguities

- ▶ ISRs average over space as well
- ▶ The spatial averaging is dependent on the pulse type used and the beam pattern



# Spatial Ambiguities from Pulse Shape

- ▶ Along the beam the spatial averaging is due to the pulse pattern
- ▶ Different pulse types yield different along range ambiguities

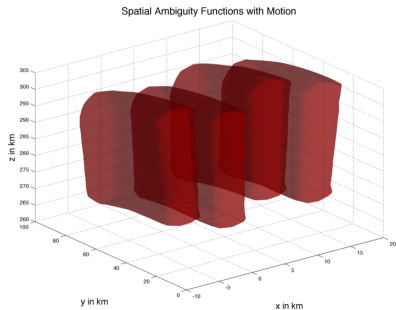
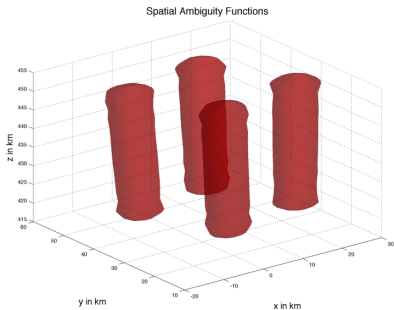


**Figure:** [Hys18]



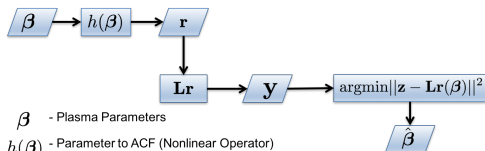
# Spatial Ambiguities from Beam Pattern

- ▶ Motion of the plasma can increase this apparent ambiguity



# Ambiguities

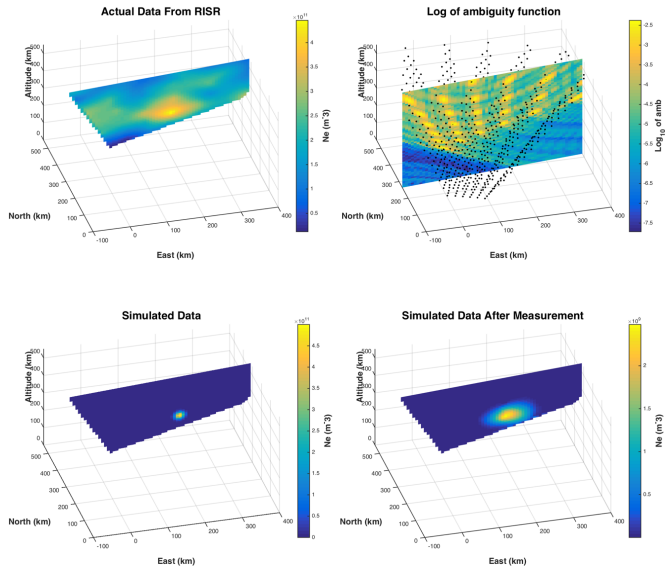
$$y(\tau_s, \mathbf{x}_s, t_s) = \int L(\tau_s, \mathbf{x}_s, t_s, \tau, \mathbf{x}, t) R(\tau, \mathbf{x}, t | \beta) dV dt d\tau$$



- $\beta$  - Plasma Parameters
- $h(\beta)$  - Parameter to ACF (Nonlinear Operator)
- $\mathbf{r}$  - ACF
- $\mathbf{Lr}$  - Space-Time Ambiguity (Linear Operator)
- $\mathbf{y}$  - Blurred ACF
- $\mathbf{Z}$  - Blurred and Noisy ACF



# Ambiguities: Data Example



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# Advance Methods of Fitting

- ▶ Active area of research to improve reconstruction of the parameters
  - ▶ Better resolution
  - ▶ Enable new measurements
    - ▶ e.g. use an extremely long pulse to measure top-side
- ▶ Data Based Inversion (Lag Profile Analysis)
  - ▶ Linear Inversion, easier computationally
- ▶ Parametric Inversion (Full Profile Analysis)
  - ▶ Non-Linear Inversion, more complex computationally

# Data Based Inversion (Lag Profile Analysis)

$$\hat{\mathbf{r}} = \arg \min_{\mathbf{r}} \|\mathbf{z} - \mathbf{Lr}\|_2^2 + \gamma \cdot \mathbf{f}(\mathbf{r}),$$

- ▶ Inversion of linear space-time ambiguity and then fit lags
- ▶ Constraints are generally functions of lags, does not connect directly to physics
- ▶ Many computational tools available as its similar to problems in other fields
  - ▶ e.g. deconvolution and image reconstruction
  - ▶ Examples: [VLN<sup>+</sup>08], [NKKS08]

# Parametric Inversion (Full Profile Analysis)

$$\hat{\beta} = \arg \min_{\beta} \|\mathbf{z} - \mathbf{Lh}(\beta)\|_2^2 + \alpha \cdot \mathbf{f}(\beta)$$

- ▶ Inversion of linear space-time ambiguity and parameter-to-lag operator ( $h(\beta)$ )
- ▶ Constraints are generally functions of plasma parameters
  - ▶ e.g.  $\langle d^2 T_e / dz^2 \rangle$ ,  $\langle d^2 T_i / dz^2 \rangle$  [HRCH08]
- ▶ Not as many computational tools available
- ▶ Examples: [HRCH08], [HRTvE92], [LHP97]

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# Gaussian processes

## Gaussian process

“A collection of random variables, any finite number of which have a joint Gaussian distribution” [Rasmussen and Williams, 2006]

- ▶ For a function  $f(\mathbf{x})$ , we write

$$f(\mathbf{x}) \sim \mathcal{GP}(m(\mathbf{x}), k(\mathbf{x}, \mathbf{x}'))$$

- ▶ Fully defined by mean and covariance functions

$$m(\mathbf{x}) = \mathbf{E}[f(\mathbf{x})]$$

$$k(\mathbf{x}, \mathbf{x}') = \mathbf{E}[(f(\mathbf{x}) - m(\mathbf{x}))(f(\mathbf{x}') - m(\mathbf{x}'))]$$

- ▶ Evaluating at points leads to a Gaussian random vector

$$\begin{bmatrix} f(\mathbf{x}_1) \\ \vdots \\ f(\mathbf{x}_N) \end{bmatrix} \sim \mathcal{N} \left( \begin{bmatrix} m(\mathbf{x}_1) \\ \vdots \\ m(\mathbf{x}_N) \end{bmatrix}, \begin{bmatrix} k(\mathbf{x}_1, \mathbf{x}_1) & \cdots & k(\mathbf{x}_1, \mathbf{x}_N) \\ \vdots & \ddots & \vdots \\ k(\mathbf{x}_N, \mathbf{x}_1) & \cdots & k(\mathbf{x}_N, \mathbf{x}_N) \end{bmatrix} \right)$$

# Gaussian processes

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“A collection of random variables, any finite number of which have a joint Gaussian distribution” [Rasmussen and Williams, 2006]

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- ▶ Evaluating at points leads to a Gaussian random vector

$$\mathbf{f}(X) \sim \mathcal{N}(\mathbf{m}(X), \mathbf{K}(X, X))$$

# Gaussian process regression: specification

**Step 1: Select forms for mean  $m(\mathbf{x})$  and covariance  $k(\mathbf{x}, \mathbf{x}')$**

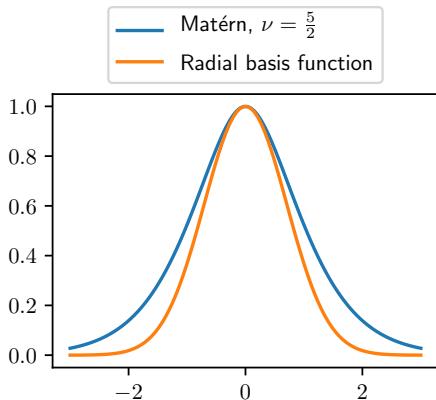
- ▶ Functions will typically have parameters  $\theta$

**Matérn covariance,  $\nu = \frac{5}{2}$**

$$k(\mathbf{x}, \mathbf{x}') = \sigma^2 \left(1 + \sqrt{5}r + \frac{5}{3}r^2\right) e^{-\sqrt{5}r}$$

with

$$r = \left\| \frac{\mathbf{x} - \mathbf{x}'}{\delta} \right\|_2$$
$$\theta = [\sigma^2 \quad \delta_1 \quad \dots \quad \delta_d]^\top$$



# Gaussian process regression: training

## Step 2: Train/fit parameters $\theta$ using measurements of $f(\mathbf{x})$

- ▶ Noisy measurements at a collection of points  $\mathbf{X}$

$$\mathbf{y} = \mathbf{f}(\mathbf{X}) + \boldsymbol{\epsilon} \quad \boldsymbol{\epsilon} \sim \mathcal{N}(\mathbf{0}, \sigma_n^2 \mathbf{I})$$

- ▶ Maximize marginal likelihood

$$p(\mathbf{y} | \mathbf{X}) = \int p(\mathbf{y} | \mathbf{f}, \mathbf{X}) p(\mathbf{f} | \mathbf{X}) d\mathbf{f}$$
$$\mathbf{y} | \mathbf{X} \sim \mathcal{N}(\mathbf{m}(\mathbf{X}), \mathbf{K}(\mathbf{X}, \mathbf{X}) + \sigma_n^2 \mathbf{I})$$

$$l(\boldsymbol{\theta}) = \log p(\mathbf{y} | \mathbf{X}) = -\frac{1}{2}(\mathbf{y} - \mathbf{m})^\top (\mathbf{K} + \sigma_n^2 \mathbf{I})^{-1} (\mathbf{y} - \mathbf{m})$$
$$- \frac{1}{2} \log \det(\mathbf{K} + \sigma_n^2 \mathbf{I}) - C$$

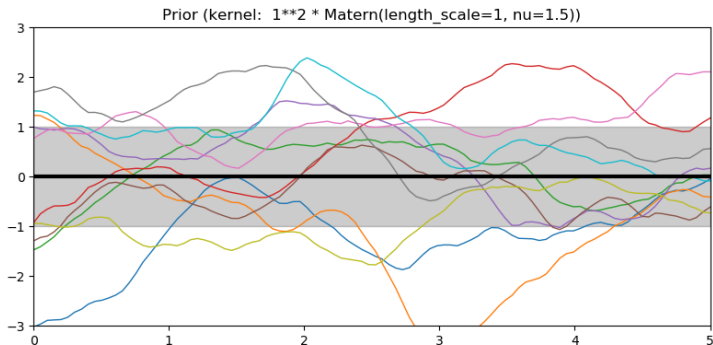
# Gaussian process regression: training

## Step 2: Train/fit parameters $\theta$ using measurements of $f(\mathbf{x})$

- ▶ Noisy measurements at a collection of points  $X$

$$\mathbf{y} = \mathbf{f}(X) + \boldsymbol{\epsilon} \quad \boldsymbol{\epsilon} \sim \mathcal{N}(\mathbf{0}, \sigma_n^2 \mathbf{I})$$

- ▶ Maximize marginal likelihood



# Gaussian process regression: prediction

## Step 3: Predict $\mathbf{f}_*$ at a collection of test points $\mathbf{X}_*$

- ▶ Joint distribution

$$\begin{bmatrix} \mathbf{y} \\ \mathbf{f}_* \end{bmatrix} \sim \mathcal{N} \left( \begin{bmatrix} \mathbf{m}(\mathbf{X}) \\ \mathbf{m}(\mathbf{X}_*) \end{bmatrix}, \begin{bmatrix} \mathbf{K}(\mathbf{X}, \mathbf{X}) + \sigma_n^2 \mathbf{I} & \mathbf{K}(\mathbf{X}, \mathbf{X}_*) \\ \mathbf{K}(\mathbf{X}_*, \mathbf{X}) & \mathbf{K}(\mathbf{X}_*, \mathbf{X}_*) \end{bmatrix} \right)$$

- ▶ Posterior distribution by conditioning on  $\mathbf{y}$

$$\mathbf{f}_* \mid \mathbf{y}, \mathbf{X}, \mathbf{X}_* \sim \mathcal{N}(\mathbf{m}_*, \mathbf{K}_*)$$

$$\mathbf{m}_* = \mathbf{m}(\mathbf{X}_*) + \mathbf{K}(\mathbf{X}_*, \mathbf{X})(\mathbf{K}(\mathbf{X}, \mathbf{X}) + \sigma_n^2 \mathbf{I})^{-1}(\mathbf{y} - \mathbf{m}(\mathbf{X}))$$

$$\mathbf{K}_* = \mathbf{K}(\mathbf{X}_*, \mathbf{X}_*) - \mathbf{K}(\mathbf{X}_*, \mathbf{X})(\mathbf{K}(\mathbf{X}, \mathbf{X}) + \sigma_n^2 \mathbf{I})^{-1} \mathbf{K}(\mathbf{X}, \mathbf{X}_*)$$

Use mean for predicted value and variance for confidence interval

# Gaussian process regression: prediction

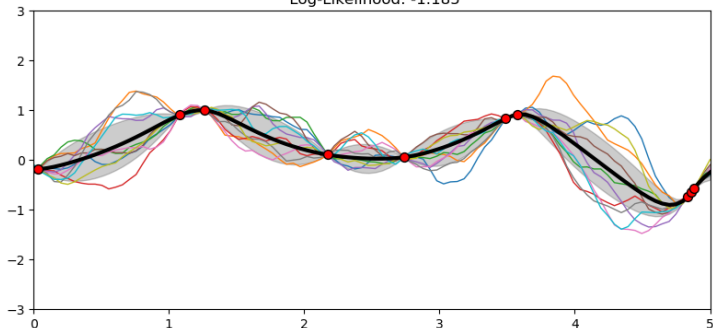
## Step 3: Predict $f_*$ at a collection of test points $X_*$

- ▶ Joint distribution

$$\begin{bmatrix} \mathbf{y} \\ \mathbf{f}_* \end{bmatrix} \sim \mathcal{N} \left( \begin{bmatrix} \mathbf{m}(X) \\ \mathbf{m}(X_*) \end{bmatrix}, \begin{bmatrix} \mathbf{K}(X, X) + \sigma_n^2 \mathbf{I} & \mathbf{K}(X, X_*) \\ \mathbf{K}(X_*, X) & \mathbf{K}(X_*, X_*) \end{bmatrix} \right)$$

- ▶ Posterior distribution by conditioning on  $\mathbf{y}$

Posterior (kernel: 0.609\*\*2 \* Matern(length\_scale=0.484, nu=1.5))  
Log-Likelihood: -1.185



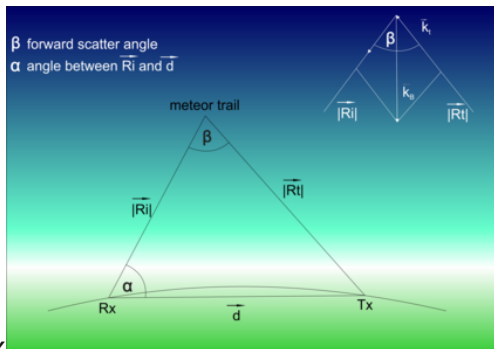
# Meteor wind measurements

- ▶ Doppler shift in Bragg direction for a single location/time

$$f(x, y, z, t) = \frac{1}{2\pi} \begin{bmatrix} k_x & k_y & k_z \end{bmatrix} \begin{bmatrix} u(x, y, z, t) \\ v(x, y, z, t) \\ w(x, y, z, t) \end{bmatrix}$$

where

- ▶  $k_x, k_y, k_z$  are Bragg vector components
- ▶  $u, v,$  and  $w$  are the unknown wind components





# Vectorized Doppler measurement equation

$$f(x, y, z, t) = \frac{1}{2\pi} \begin{bmatrix} k_x & k_y & k_z \end{bmatrix} \begin{bmatrix} u(x, y, z, t) \\ v(x, y, z, t) \\ w(x, y, z, t) \end{bmatrix}$$

- Measure at a set of points  $\mathbf{X}$  with noise  $\boldsymbol{\epsilon}$

$$\mathbf{y}(\mathbf{X}) = \mathbf{a}_u \odot \mathbf{u} + \mathbf{a}_v \odot \mathbf{v} + \mathbf{a}_w \odot \mathbf{w} + \boldsymbol{\epsilon}$$

$$\mathbf{X} = \begin{bmatrix} \mathbf{x}_1^\top \\ \vdots \\ \mathbf{x}_M^\top \end{bmatrix} = \begin{bmatrix} x_1 & y_1 & z_1 & t_1 \\ \vdots & \vdots & \vdots & \vdots \\ x_M & y_M & z_M & t_M \end{bmatrix} \quad \boldsymbol{\epsilon} \sim \mathcal{N}(0, \Sigma_n)$$

$$\mathbf{a}_u = \frac{1}{2\pi} \begin{bmatrix} k_{x1} \\ \vdots \\ k_{xM} \end{bmatrix} \quad \mathbf{a}_v = \frac{1}{2\pi} \begin{bmatrix} k_{y1} \\ \vdots \\ k_{yM} \end{bmatrix} \quad \mathbf{a}_w = \frac{1}{2\pi} \begin{bmatrix} k_{z1} \\ \vdots \\ k_{zM} \end{bmatrix}$$

$$\mathbf{u} = \begin{bmatrix} u(\mathbf{x}_1) \\ \vdots \\ u(\mathbf{x}_M) \end{bmatrix} \quad \mathbf{v} = \begin{bmatrix} v(\mathbf{x}_1) \\ \vdots \\ v(\mathbf{x}_M) \end{bmatrix} \quad \mathbf{w} = \begin{bmatrix} w(\mathbf{x}_1) \\ \vdots \\ w(\mathbf{x}_M) \end{bmatrix}$$

# Gaussian process prior for winds

- ▶ Model each wind component as a Gaussian process

$$u(\mathbf{x}) \sim \mathcal{GP}(m_u(\mathbf{x}), k_u(\mathbf{x}, \mathbf{x}'))$$

$$v(\mathbf{x}) \sim \mathcal{GP}(m_v(\mathbf{x}), k_v(\mathbf{x}, \mathbf{x}'))$$

$$w(\mathbf{x}) \sim \mathcal{GP}(m_w(\mathbf{x}), k_w(\mathbf{x}, \mathbf{x}'))$$

- ▶ Choose prior mean and covariance for  $u, v, w$

## Constant means

$$m_u(\mathbf{x}) = u_0$$

$$m_v(\mathbf{x}) = v_0$$

$$m_w(\mathbf{x}) = w_0$$

## Common Matérn covariance

$$\begin{aligned} k_u(\mathbf{x}, \mathbf{x}') &= k_v(\mathbf{x}, \mathbf{x}') = k_w(\mathbf{x}, \mathbf{x}') \\ &= k_{\text{Matérn}, \nu=\frac{5}{2}}(\mathbf{x}, \mathbf{x}'; \sigma^2, \delta_x, \delta_y, \delta_z, \delta_t) \end{aligned}$$

- ▶ Can fit parameters and/or apply physical knowledge



# Gaussian prior for Doppler measurements

$$u(\mathbf{x}) \sim \mathcal{GP}(m_u(\mathbf{x}), k_u(\mathbf{x}, \mathbf{x}'))$$

$$v(\mathbf{x}) \sim \mathcal{GP}(m_v(\mathbf{x}), k_v(\mathbf{x}, \mathbf{x}')) \quad \mathbf{y}(X) = \mathbf{a}_u \odot \mathbf{u} + \mathbf{a}_v \odot \mathbf{v} + \mathbf{a}_w \odot \mathbf{w} + \epsilon$$

$$w(\mathbf{x}) \sim \mathcal{GP}(m_w(\mathbf{x}), k_w(\mathbf{x}, \mathbf{x}'))$$

- ▶ Multivariate Gaussian for winds at measurement points

$$\begin{bmatrix} \mathbf{u} \\ \mathbf{v} \\ \mathbf{w} \end{bmatrix} \sim \mathcal{N} \left( \begin{bmatrix} \mathbf{m}_u(X) \\ \mathbf{m}_v(X) \\ \mathbf{m}_w(X) \end{bmatrix}, \begin{bmatrix} \mathbf{K}_u(X, X) & 0 & 0 \\ 0 & \mathbf{K}_v(X, X) & 0 \\ 0 & 0 & \mathbf{K}_w(X, X) \end{bmatrix} \right)$$

- ▶ Resulting multivariate Gaussian for Doppler measurements

$$\mathbf{y} \sim \mathcal{N}(\mathbf{m}_y(X), \mathbf{K}_y(X, X))$$

$$\mathbf{m}_y(X) = \mathbf{a}_u \odot \mathbf{m}_u(X) + \mathbf{a}_v \odot \mathbf{m}_v(X) + \mathbf{a}_w \odot \mathbf{m}_w(X)$$

$$\mathbf{K}_y(X, X) = (\mathbf{a}_u \mathbf{a}_u^\top) \odot \mathbf{K}_u(X, X) + (\mathbf{a}_v \mathbf{a}_v^\top) \odot \mathbf{K}_v(X, X) + (\mathbf{a}_w \mathbf{a}_w^\top) \odot \mathbf{K}_w(X, X) + \Sigma_n$$



# Gaussian prior for Doppler measurements

$$u(\mathbf{x}) \sim \mathcal{GP}(m_u(\mathbf{x}), k_u(\mathbf{x}, \mathbf{x}'))$$

$$v(\mathbf{x}) \sim \mathcal{GP}(m_v(\mathbf{x}), k_v(\mathbf{x}, \mathbf{x}')) \quad \mathbf{y}(\mathbf{X}) = \mathbf{a}_u \odot \mathbf{u} + \mathbf{a}_v \odot \mathbf{v} + \mathbf{a}_w \odot \mathbf{w} + \boldsymbol{\epsilon}$$

$$w(\mathbf{x}) \sim \mathcal{GP}(m_w(\mathbf{x}), k_w(\mathbf{x}, \mathbf{x}'))$$

- ▶ Multivariate Gaussian for winds at measurement points

$$\begin{bmatrix} \mathbf{u} \\ \mathbf{v} \\ \mathbf{w} \end{bmatrix} \sim \mathcal{N} \left( \begin{bmatrix} \mathbf{m}_u(\mathbf{X}) \\ \mathbf{m}_v(\mathbf{X}) \\ \mathbf{m}_w(\mathbf{X}) \end{bmatrix}, \begin{bmatrix} \mathbf{K}_u(\mathbf{X}, \mathbf{X}) & 0 & 0 \\ 0 & \mathbf{K}_v(\mathbf{X}, \mathbf{X}) & 0 \\ 0 & 0 & \mathbf{K}_w(\mathbf{X}, \mathbf{X}) \end{bmatrix} \right)$$

- ▶ Resulting multivariate Gaussian for Doppler measurements

$$\mathbf{y} \sim \mathcal{N}(\mathbf{m}_y(\mathbf{X}), \mathbf{K}_y(\mathbf{X}, \mathbf{X}))$$

$$\mathbf{m}_y(\mathbf{X}) = \mathbf{a}_u \odot \mathbf{m}_u(\mathbf{X}) + \mathbf{a}_v \odot \mathbf{m}_v(\mathbf{X}) + \mathbf{a}_w \odot \mathbf{m}_w(\mathbf{X})$$

$$\mathbf{K}_y(\mathbf{X}, \mathbf{X}) = (\mathbf{a}_u \mathbf{a}_u^\top) \odot \mathbf{K}_u(\mathbf{X}, \mathbf{X}) + (\mathbf{a}_v \mathbf{a}_v^\top) \odot \mathbf{K}_v(\mathbf{X}, \mathbf{X}) \\ + (\mathbf{a}_w \mathbf{a}_w^\top) \odot \mathbf{K}_w(\mathbf{X}, \mathbf{X}) + \Sigma_n$$

# Doppler measurement fitting

$$\begin{aligned}\mathbf{m}_y(\mathbf{X}) &= \mathbf{a}_u \odot \mathbf{m}_u(\mathbf{X}) + \mathbf{a}_v \odot \mathbf{m}_v(\mathbf{X}) + \mathbf{a}_w \odot \mathbf{m}_w(\mathbf{X}) \\ \mathbf{K}_y(\mathbf{X}, \mathbf{X}) &= (\mathbf{a}_u \mathbf{a}_u^\top) \odot \mathbf{K}_u(\mathbf{X}, \mathbf{X}) + (\mathbf{a}_v \mathbf{a}_v^\top) \odot \mathbf{K}_v(\mathbf{X}, \mathbf{X}) \\ &\quad + (\mathbf{a}_w \mathbf{a}_w^\top) \odot \mathbf{K}_w(\mathbf{X}, \mathbf{X}) + \Sigma_n\end{aligned}$$

- ▶ Maximize likelihood

$$l(\boldsymbol{\theta}) = -\frac{1}{2}(\mathbf{y} - \mathbf{m}_y)^\top \mathbf{K}_y^{-1}(\mathbf{y} - \mathbf{m}_y) - \frac{1}{2} \log \det \mathbf{K}_y - C$$

## Resulting parameters: March 14, 2016, 08:00 - 12:00

$$u_0 = -20 \text{ m/s}$$

$$v_0 = -10 \text{ m/s}$$

$$w_0 = -2 \text{ m/s}$$

$$\sigma^2 = 500 \text{ (m/s)}^2$$

$$\delta_x = 40 \text{ km}$$

$$\delta_y = 20 \text{ km}$$

$$\delta_z = 2 \text{ km}$$

$$\delta_t = 30 \text{ min}$$

# Wind estimation

- ▶ Can write posterior distribution for winds at prediction points  $X_*$

$$\begin{bmatrix} \mathbf{y} \\ \mathbf{u}_* \\ \mathbf{v}_* \\ \mathbf{w}_* \end{bmatrix} \sim \mathcal{N} \left( \begin{bmatrix} \mathbf{m}_y(X) \\ \mathbf{m}_u(X_*) \\ \mathbf{m}_v(X_*) \\ \mathbf{m}_w(X_*) \end{bmatrix}, \kappa \right)$$

$$\kappa = \begin{bmatrix} K_y(X, X) & \mathbf{a}_u \odot K_u(X, X_*) & \mathbf{a}_v \odot K_v(X, X_*) & \mathbf{a}_w \odot K_w(X, X_*) \\ K_u(X_*, X) \odot \mathbf{a}_u & K_u(X_*, X_*) & 0 & 0 \\ K_v(X_*, X) \odot \mathbf{a}_v & 0 & K_v(X_*, X_*) & 0 \\ K_w(X_*, X) \odot \mathbf{a}_w & 0 & 0 & K_w(X_*, X_*) \end{bmatrix}$$

- ▶ Estimate given by mean (just linear algebra)

$$\mathbf{E}[\mathbf{u}_* | \mathbf{y}] = \mathbf{m}_u(X_*) + K_u(X_*, X) \odot \mathbf{a}_u \odot K_y(X, X)^{-1} (\mathbf{y} - \mathbf{m}_y(X))$$

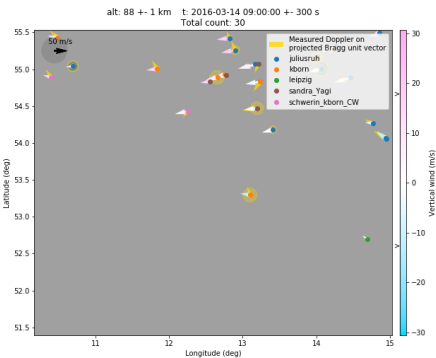
$$\mathbf{E}[\mathbf{v}_* | \mathbf{y}] = \mathbf{m}_v(X_*) + K_v(X_*, X) \odot \mathbf{a}_v \odot K_y(X, X)^{-1} (\mathbf{y} - \mathbf{m}_y(X))$$

$$\mathbf{E}[\mathbf{w}_* | \mathbf{y}] = \mathbf{m}_w(X_*) + K_w(X_*, X) \odot \mathbf{a}_w \odot K_y(X, X)^{-1} (\mathbf{y} - \mathbf{m}_y(X))$$

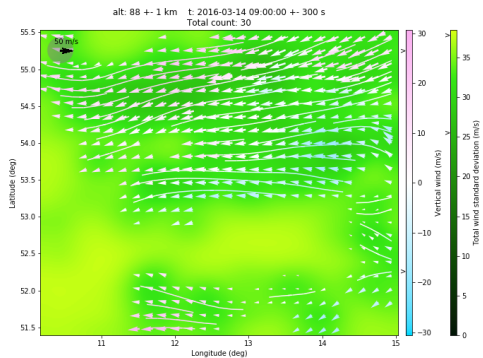
- ▶ Posterior covariance can be calculated as well

# Example wind field estimates

## Measurements



## Estimates



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